Notice of Allowability	Application No.	Applicant(s)
	10/646,681	LEI ET AL.
	Examiner	Art Unit
	04-11-14-15 1	0040
·	Stanetta D. Isaac	2812
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this apport or other appropriate communication GHTS. This application is subject to	plication. If not included will be mailed in due course. THIS
1. \boxtimes This communication is responsive to <u>the Interview Summan</u>	ry filed on 5/24/07.	
2. X The allowed claim(s) is/are 1,3,4,7,9-12,14,15,19-25,27,28	,30 and 33-49.	
 3. ☐ Acknowledgment is made of a claim for foreign priority un a) ☐ All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have 		
2. Certified copies of the priority documents have been received in Application No		
3. Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		complying with the requirements
4. A SUBSTITUTE OATH OR DECLARATION must be subminification (PTO-152) which give		
5. ☐ CORRECTED DRAWINGŠ (as "replacement sheets") mus	t be submitted.	
(a) including changes required by the Notice of Draftspers	· · · · · · · · · · · · · · · · · · ·	948) attached
1) hereto or 2) to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the C	Office action of
Identifying indicia such as the application number (see 37 CFR 1, each sheet. Replacement sheet(s) should be labeled as such in the		
6. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT		
Attachment(s)		
1. Notice of References Cited (PTO-892)	Notice of Informal P	atent Application
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ☑ Interview Summary	
3. Information Disclosure Statements (PTO/SB/08),	Paper No./Mail Dat 7. ⊠ Examiner's Amendr	
Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit	8. X Examiner's Stateme	ent of Reasons for Allowance
of Biological Material	9. 🗌 Other	1////
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	MICHAE SUPERVISOR	L LEBENTRITT Y PATENT EXAMINER

Application/Control Number: 10/646,681

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EXAMINER'S AMENDMENT

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Michael A. Bernadicou on 5/24/07.

The application has been amended as follows:

In claim 1, line 3, after "first dielectric film" insert—to a thickness greater than 3000 Å—

In claim 1, line 10, delete "GO1", and insert instead—GOI—

In claim 12, line 6, after "first dielectric film" insert—to a thickness greater than 3000

Å---

Å---

In claim 22, line 3, after "first dielectric film" insert—to a thickness greater than 3000

In claim 33, line 4, delete "the first dielectric film sufficiently thick to cover the surface roughness of the epitaxial germanium layer", and insert instead—to a thickness greater than 3000 Å;—

In claim 39, line 6, after "a first dielectric film" insert—to a thickness greater than 3000 Å—

In claim 39, line 6, delete ",the first dielectric film sufficiently thick to cover the surface roughness of the epitaxial germanium layer"

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In claim 44, line 4, delete "the first dielectric film sufficiently thick to cover the surface roughness of the epitaxial germanium layer", and insert instead—to a thickness greater than 3000 Å—

REASONS FOR ALLOWANCE

The following is an examiner's statement of reasons for allowance:

The closest prior art of record, Reisman et al., US Patent 4,891,329, fails to show the following steps of:

Pertaining to independent claim 1 and 22,"forming a first dielectric film to a thickness greater than 3000 Å on top of the epitaxial germanium layer;"

Pertaining to independent claims 12 and 39,"forming a first dielectric to a thickness greater than 3000 Å on top of the rough surface;"

Pertaining to independent claims 33 and 44,"forming a first dielectric film on top of the epitaxial germanium layer to a thickness greater than 3000 Å,"

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Stanetta D. Isaac whose telephone number is 571-272-1671. The examiner can normally be reached on Monday-Friday 9:30am -6:30pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Lebentritt can be reached on 571-272-1873. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Stanetta Isaac Patent Examiner May 26, 2007

MICHAEL LEBENTRITT
SUPERVISORY PATENT EXAMINER